

ERRATA

Single versus successive pop-in modes in nanoindentation tests of single crystals – ERRATUM

Yuzhi Xia, Yanfei Gao, George M. Pharr, and Hongbin Bei

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Study of phase separation in an InGaN alloy by electron energy loss spectroscopy in an aberration corrected monochromated scanning transmission electron microscope – ERRATUM

Thomas Walther, Xiaoyi Wang, Veerendra C. Angadi, Pierre Ruterana, Paolo Longo, and Toshihiro Aoki

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Length-dependent melting behavior of Sn nanowires – ERRATUM

Qiyue Yin, Fan Gao, Jirui Wang, Zhiyong Gu, Eric A. Stach, and Guangwen Zhou

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Determination of the strain-rate sensitivity of ultrafine-grained materials by spherical nanoindentation – ERRATUM

Patrick Feldner, Benoit Merle, and Mathias Göken

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Fluorographene: Synthesis and sensing applications – ERRATUM

Tharangattu N. Narayanan, Ravi K. Biroju, and Venkatesan Renugopalakrishnan

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Electromagnetic interference shielding and mechanical properties of Si₃N₄-SiOC composites fabricated by 3D-printing combined with polymer infiltration and pyrolysis – ERRATUM

Wenyan Duan, Zhe Fan, Hui Wang, Jingyi Zhang, Tianlu Qiao, and Xiaowei Yin

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The six articles composing this erratum were missing their respective footnotes in their original publications for authors who were also editors on the journal. The authors who were missing these corresponding footnotes are, respectively, George M. Pharr,¹ Thomas Walther,² Eric A. Stach,³ Mathias Göken,⁴ Venkatesan Renugopalakrishnan,⁵ and Xiaowei Yin.⁶ The disclosure footnote is as follows:

This author was an editor of this journal during the review and decision stage. For the *JMR* policy on review and publication of manuscripts authored by editors, please refer to <http://www.mrs.org/editor-manuscripts/>.

The publisher regrets these errors, and the originals have since been updated.

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4. P. Feldner, B. Merle, and M. Göken: Determination of the strain-rate sensitivity of ultrafine-grained materials by spherical nanoindentation. *J Mater. Res.* **32**(8), 1466–1473 (2017). doi: 10.1557/jmr.2017.69.
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6. W. Duan, Z. Fan, H. Wang, J. Zhang, T. Qiao, and X. Yin: Electromagnetic interference shielding and mechanical properties of Si₃N₄-SiOC composites fabricated by 3D-printing combined with polymer infiltration and pyrolysis. *J Mater. Res.* (2017). doi: 10.1557/jmr.2017.150.